



DESCRIPTION

The AM4614 is available in SOP8 package.

PACKAGE	CH	BVDSS	RDSON	ID
SOP8	N	40V	26mΩ	7.2A
	P	-40V	38mΩ	-7.5A

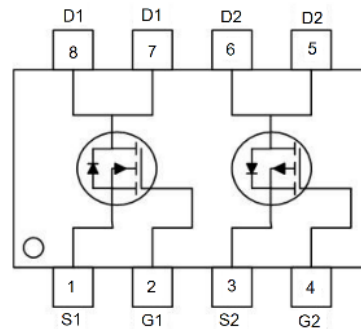
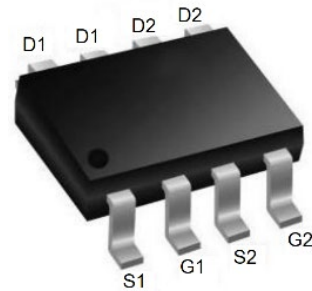
FEATURE

- $R_{DS(ON)} = 26m\Omega(Typ.)@V_{GS} = 10V$
 $R_{DS(ON)} = 35m\Omega(Typ.)@V_{GS} = 4.5V$
 $R_{DS(ON)} = 38m\Omega(Typ.)@V_{GS} = -10V$
 $R_{DS(ON)} = 58m\Omega(Typ.)@V_{GS} = -4.5V$
- Low Gate Charge

APPLICATION

- Super Low Gate Charge
- Excellent CdV//dt Effect Decline
- Advanced High Cell Density Trench Technology

PIN DESCRIPTION



ORDERING INFORMATION

Package Type	Part Number	
SOP8	M8	AM4614M8R
SPQ: 3,000/Reel		AM4614M8VR
Note	R: Tape & Reel V: Halogen free Package	
AiT provides all RoHS products		

Pin #	Symbol	Function
1	S1	Source
2	G1	Gate
3	S2	Source
4	G2	Gate
5	D2	Drain
6	D2	Drain
7	D1	Drain
8	D1	Drain

**ABSOLUTE MAXIMUM RATINGS**

Parameter	Symbol	N-CH	P-CH	Unit	
Drain-Source Voltage	V_{DS}	40	-40	V	
Gate-Source Voltage	V_{GS}	± 20	± 20	V	
Continuous Drain Current, $V_{GS}@10V^{(1)}$	$T_C=25^\circ C$	7.2	-7.5	A	
	$T_C=100^\circ C$	5.6	-5.1	A	
Pulsed Drain Current ⁽²⁾	I_{DM}	14.5	-13	A	
Single Pulse Avalanche Energy	EAS	28	66	mJ	
Avalanche Current	I_{AS}	17.8	-27.2	A	
Total Power Dissipation	$T_C=25^\circ C$	P_D	2.5	3.1	W
Storage Temperature Range	T_{STG}	-55°C ~ +150		°C	
Operation Junction Temperature	T_J	-55°C ~ +150		°C	

Stresses above may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated in the Electrical Characteristics are not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

(1) Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature

(2) Pulse Test: Pulse Width $\leq 300\mu s$, Duty Cycle $\leq 0.5\%$



ELECTRICAL CHARACTERISTICS

T_J= 25°C, unless otherwise noted

Parameter	Symbol	Conditions	Min	Typ.	Max	Unit
Off Characteristic						
Drain-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} =0V, I _D =250μA	40	-	-	V
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =40 V, V _{GS} =0V	-	-	1.0	μA
Gate to Body Leakage Current	I _{GSS}	V _{DS} = 0V, V _{GS} =±20V	-	-	±100	nA
On Characteristic						
Gate Threshold Voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D =250μA	1.0	1.5	2.5	V
Static Drain-Source On-Resistance	R _{DS(ON)}	V _{GS} =10V, I _D =4A	-	26	40	mΩ
		V _{GS} =4.5V, I _D =3A	-	35	60	
Dynamic and Switching Characteristics						
Input Capacitance	C _{iss}	V _{DS} =20V, V _{GS} =0V, f=1.0MHz	-	435	-	pF
Output Capacitance	C _{oss}		-	58	-	
Reverse Transfer Capacitance	C _{rss}		-	35	-	
Total Gate Charge	Q _g	V _{DS} =20V, I _D =3A, V _{GS} =10V	-	11	-	nC
Gate-Source Charge	Q _{gs}		-	2	-	
Gate-Drain ("Miller") Charge	Q _{gd}		-	2.5	-	
Switching Characteristics						
Turn-On Delay Time	t _{d(on)}	V _{DS} =20V, I _D =4A, R _L =1Ω, R _{GEN} =3Ω, V _{GS} =10V	-	10	-	nS
	t _r		-	8	-	
Turn-Off Delay Time	t _{d(off)}		-	29	-	
	t _f		-	12	-	
Drain-Source Diode Characteristics and Maximum Ratings						
Maximum Continuous Drain to Source Diode Forward Current	I _S	-	-	-	7.2	A
Maximum Pulsed Drain to Source Diode Forward Current	I _{SM}	-	-	-	20	A
Drain to Source Diode Forward Voltage	V _{SD}	V _{GS} =0V, I _S =5A	-	-	1.2	V
Body Diode Reverse Recovery Time	t _{rr}		-	20	-	ns
Body Diode Reverse Recovery Charge	Q _{rr}	T _J =25°C, I _F =5A, dI/dt=100A/μs	-	11	-	nC



P-CHANNEL ELECTRICAL CHARACTERISTICS

T_J = 25°C, unless otherwise noted

Parameter	Symbol	Conditions	Min	Typ.	Max	Unit
Off Characteristic						
Drain-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} =0V, I _D =-250μA	-40	-	-	V
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =-40 V, V _{GS} =0V	-	-	-1	μA
Gate to Body Leakage Current	I _{GSS}	V _{DS} = 0V, V _{GS} =±20V	-	-	±100	nA
On Characteristic						
Gate Threshold Voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D =-250μA	-1.0	-1.6	-2.5	V
Static Drain-Source On-Resistance	R _{DS(ON)}	V _{GS} =-10V, I _D =-6A	-	38	53	mΩ
		V _{GS} =-4.5V, I _D =-4A	-	58	81	
Dynamic and Switching Characteristics						
Input Capacitance	C _{iss}	V _{DS} =-20V, V _{GS} =0V, f=1.0MHz	-	860	-	pF
Output Capacitance	C _{oss}		-	87	-	
Reverse Transfer Capacitance	C _{rss}		-	70	-	
Total Gate Charge	Q _g	V _{DS} =-20V, I _D =-6A, V _{GS} =-10V	-	13	-	nC
Gate-Source Charge	Q _{gs}		-	3.8	-	
Gate-Drain ("Miller") Charge	Q _{gd}		-	3.1	-	
Switching Characteristics						
Turn-On Delay Time	t _{d(on)}	V _{DS} =-20V, R _L =2.3Ω, V _{GS} =-10V R _{GEN} =6Ω	-	7.5	-	nS
	t _r		-	5.5	-	
Turn-Off Delay Time	t _{d(off)}		-	19	-	
	t _f		-	7	-	
Drain-Source Diode Characteristics and Maximum Ratings						
Maximum Continuous Drain to Source Diode Forward Current	I _S	-	-	-	-7.5	A
Maximum Pulsed Drain to Source Diode Forward Current	I _{SM}	-	-	-	-24	A
Drain to Source Diode Forward Voltage	V _{SD}	V _{GS} =0V, I _S =-6A	-	-	-1.2	V



TYPICAL PERFORMANCE CHARACTERISTICS-N

Fig 1. Output Characteristics

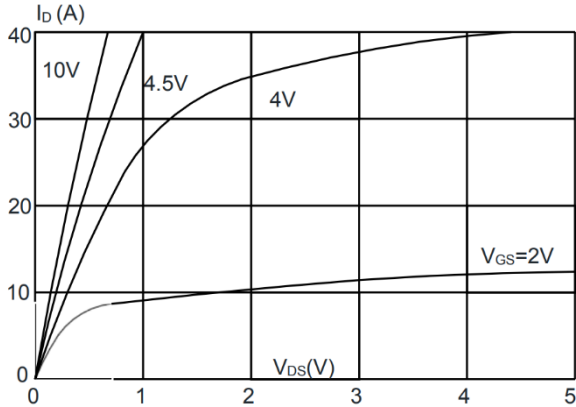


Fig 2. Typical Transfer Characteristics

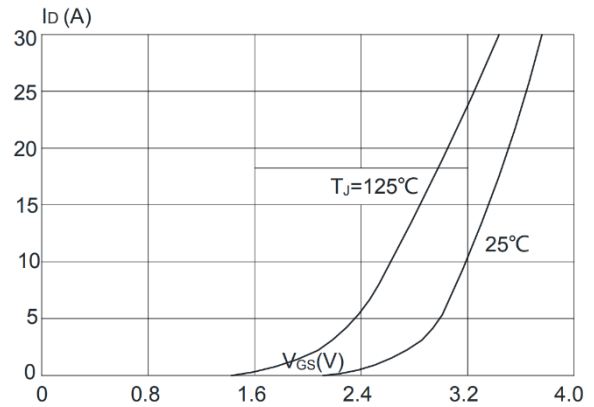


Fig 3. On-Resistance vs. Drain Current

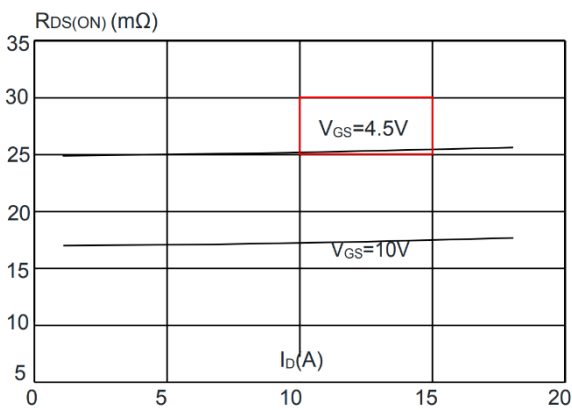


Fig 4. Body Diode Characteristics

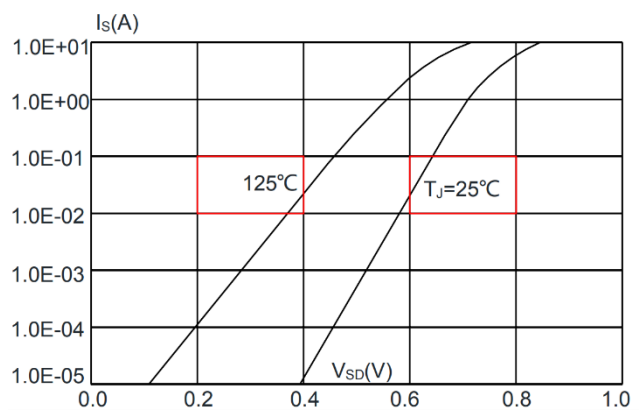


Fig 5. Gate Charge Characteristics

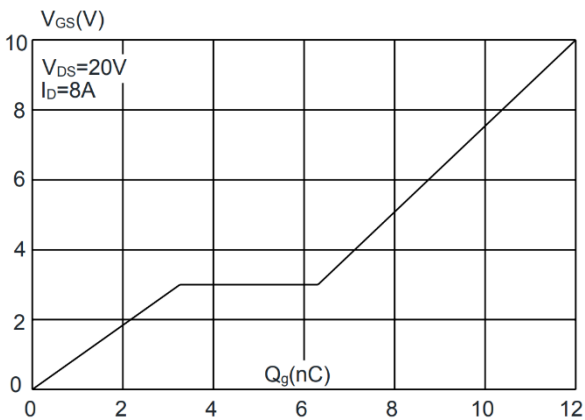


Fig 6. Capacitance Characteristics

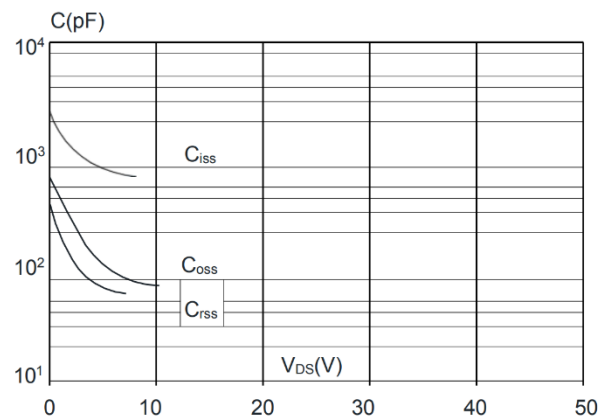




Fig 7. Normalized Breakdown Voltage vs. Junction Temperature

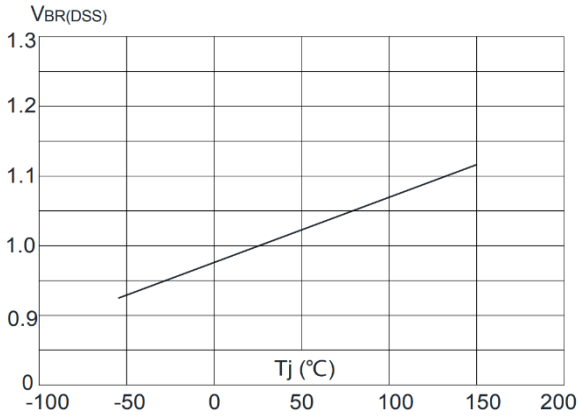


Fig 8. Normalized on Resistance vs. Junction Temperature

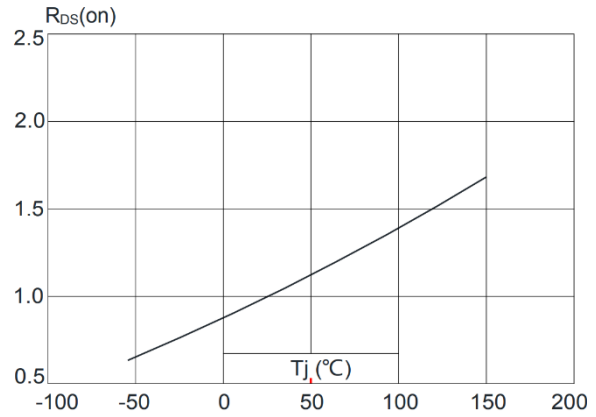


Fig 9. Maximum Safe Operation Area

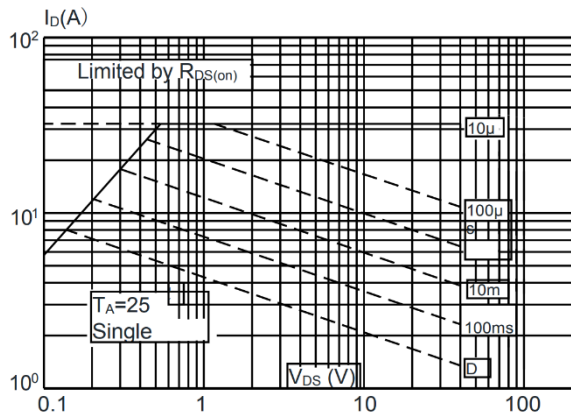


Fig 10. Maximum Continuous Drain Current vs. Ambient Temperature

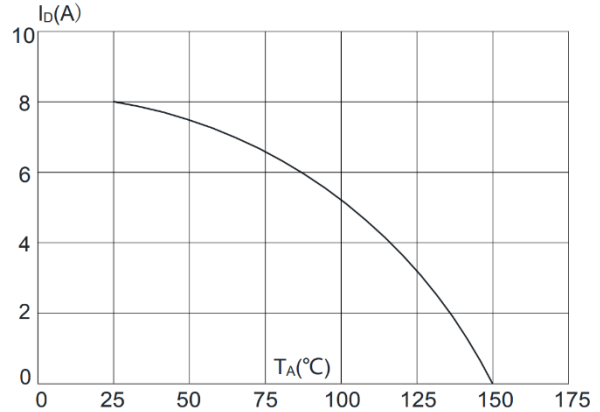
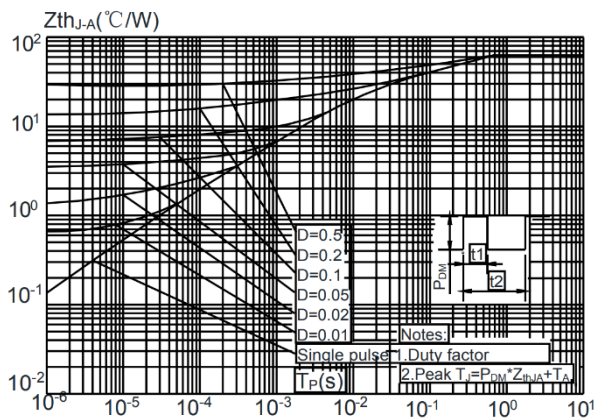


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Ambient





TYPICAL PERFORMANCE CHARACTERISTICS-P

Fig 1. Output Characteristics

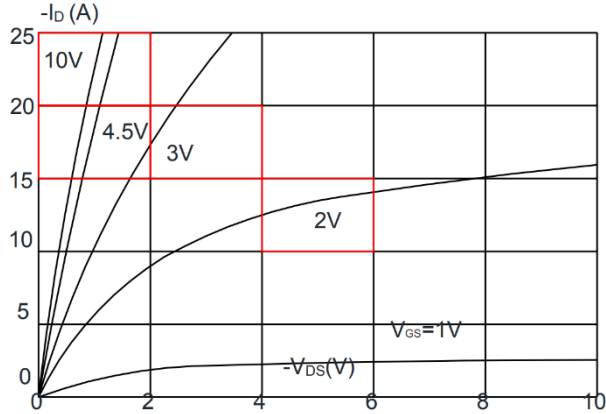


Fig 2. Typical Transfer Characteristics

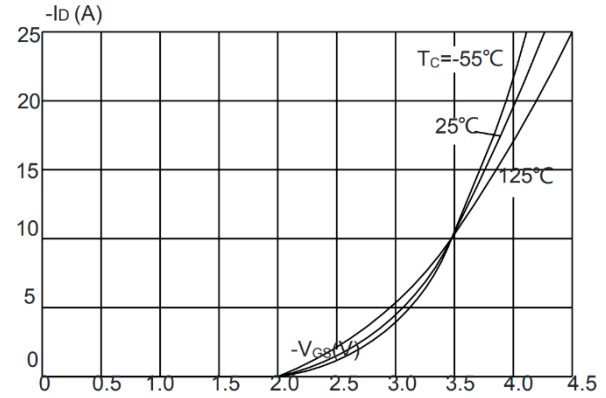


Fig 3. On-Resistance vs. Drain Current

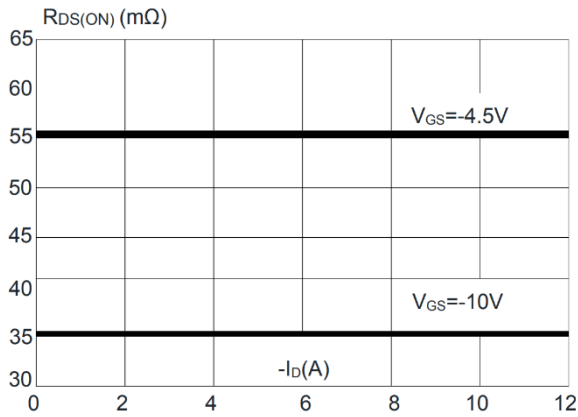


Fig 4. Body Diode Characteristics

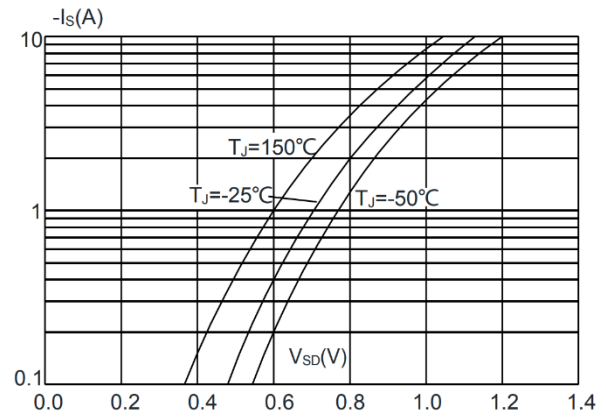


Fig 5. Gate Charge Characteristics

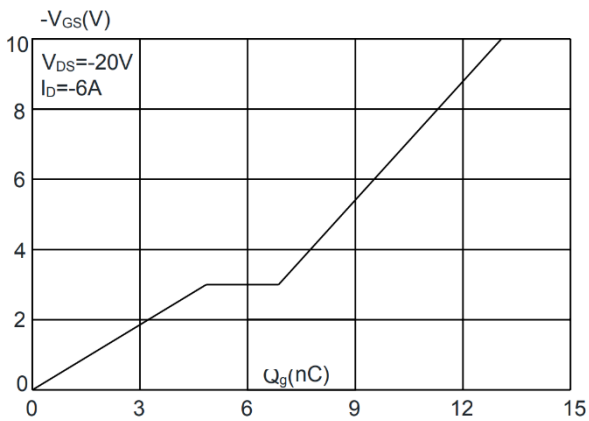


Fig 6. Capacitance Characteristics

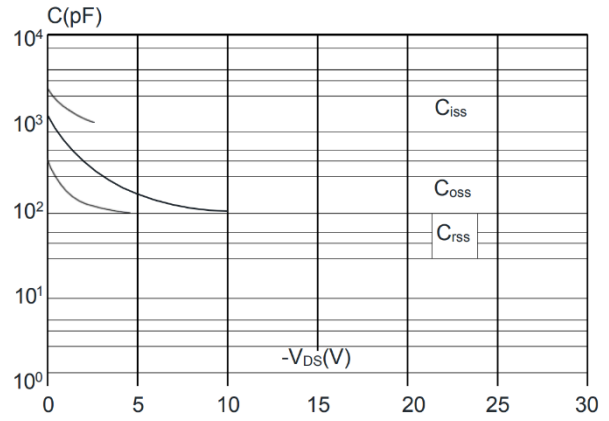




Fig 7. Normalized Breakdown Voltage vs. Junction Temperature

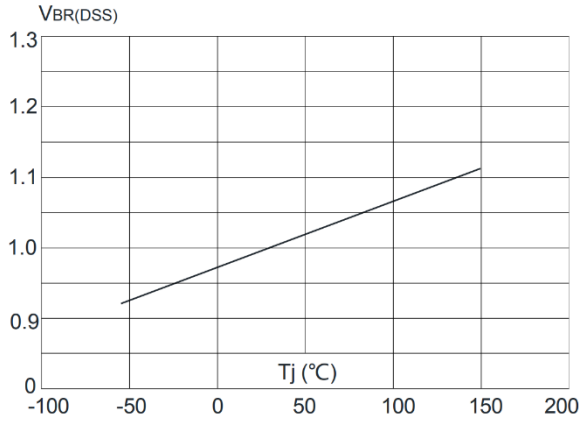


Fig 8. Normalized on Resistance vs. Junction Temperature

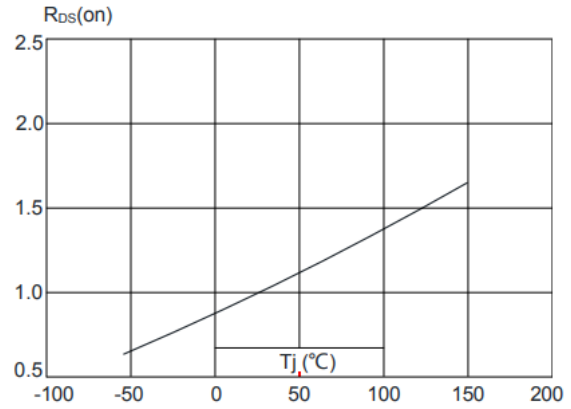


Fig 9. Maximum Safe Operation Area

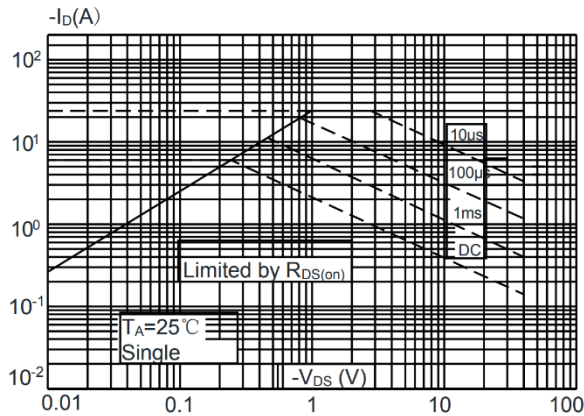


Fig 10. Maximum Continuous Drain Current vs. Ambient Temperature

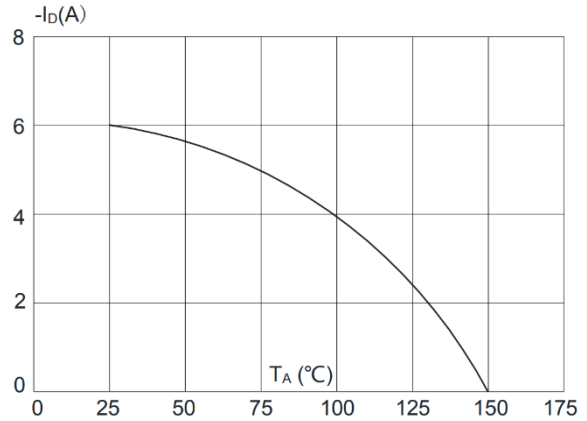
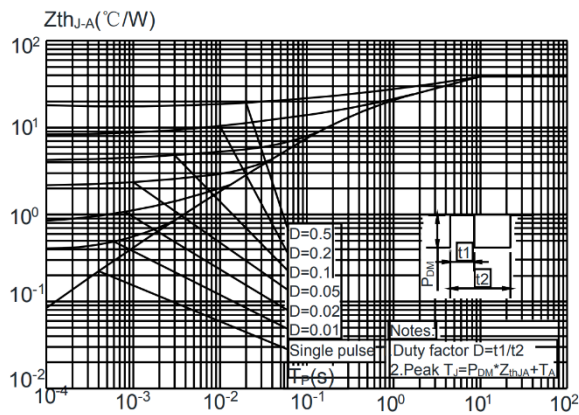


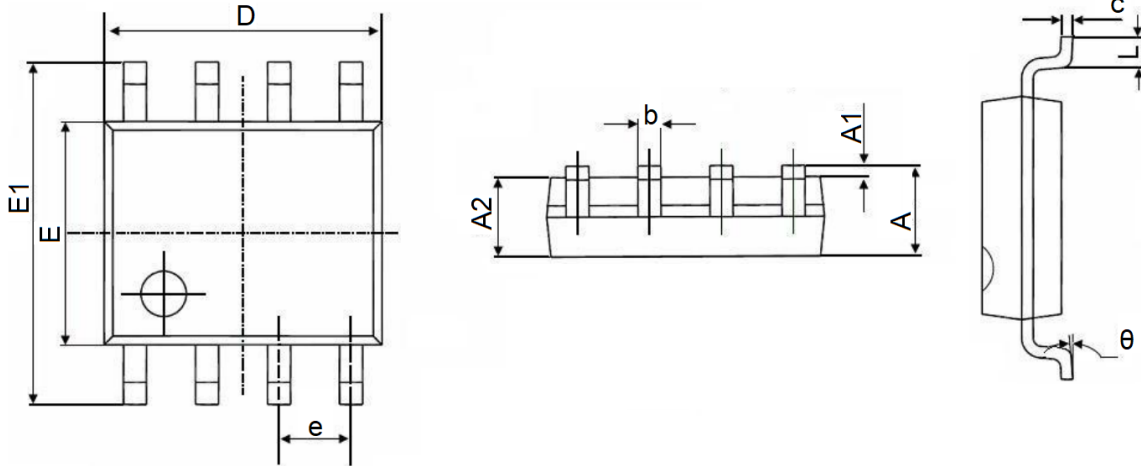
Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Ambient





PACKAGE INFORMATION

Dimension in SOP8 (unit: mm)



Symbol	Millimeters	
	Min.	Max.
A	1.350	1.750
A1	0.100	0.250
A2	1.350	1.550
b	0.330	0.510
c	0.170	0.250
D	4.700	5.100
E	3.800	4.000
E1	5.800	6.200
e	1.270 BSC	
L	0.400	1.270
θ	0°	8°



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